



# TSV912H, TSV912AH

High temperature  
rail-to-rail input/output 8 MHz operational amplifiers

## Features

- Rail-to-rail input and output
- Wide bandwidth
- Low power consumption: 820  $\mu$ A typ
- Unity gain stability
- High output current: 35 mA
- Operating range from 2.5 to 5.5 V
- Low input bias current, 1 pA typ
- ESD internal protection  $\geq$  5 kV
- Latch-up immunity

## Applications

- Automotive products

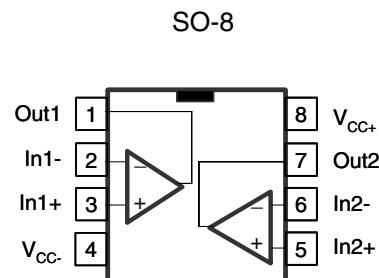
## Description

The TSV912H and TSV912AH operational amplifiers offer low voltage operation and rail-to-rail input and output.

The devices feature an excellent speed/power consumption ratio, offering an 8 MHz gain-bandwidth product while consuming only 1.1 mA maximum at 5 V. They are unity gain stable and feature an ultra-low input bias current.

The TSV912H is a high temperature version of the TSV912, and can operate from -40°C to +150°C with unique characteristics. Its main target applications are automotive, but the device is also ideal for sensor interfaces, battery-supplied and portable applications, as well as active filtering.

**Pin connections**  
(top view)



# 1 Absolute maximum ratings and operating conditions

**Table 1. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{CC}$	Supply voltage <sup>(1)</sup> ( $V_{CC+} - V_{CC-}$ )	6	V
$V_{id}$	Differential input voltage <sup>(2)</sup>	$\pm V_{CC}$	V
$V_{in}$	Input voltage <sup>(3)</sup>	$V_{CC-} -0.2$ to $V_{CC+} +0.2$	V
$I_{in}$	Input current <sup>(4)</sup>	10	mA
$T_{stg}$	Storage temperature	-65 to +150	°C
$R_{thja}$	Thermal resistance junction to ambient <sup>(5) (6)</sup> SO-8	125	°C/W
$R_{thjc}$	Thermal resistance junction to case <sup>(5) (6)</sup> SO-8	40	°C/W
$T_j$	Maximum junction temperature	160	°C
ESD	HBM: human body model <sup>(7)</sup>	5	kV
	MM: machine model <sup>(8)</sup>	400	V
	CDM: charged device model <sup>(9)</sup>	1500	V
	Latch-up immunity	200	mA

1. All voltage values, except differential voltage, are with respect to network ground terminal.
2. Differential voltages are the non-inverting input terminal with respect to the inverting input terminal.
3.  $V_{CC} - V_{in}$  must not exceed 6 V.
4. Input current must be limited by a resistor in series with the inputs.
5. Short-circuits can cause excessive heating and destructive dissipation.
6.  $R_{th}$  are typical values.
7. Human body model: a 100 pF capacitor is charged to the specified voltage, then discharged through a 1.5kΩ resistor between two pins of the device. This is done for all couples of connected pin combinations while the other pins are floating.
8. Machine model: a 200 pF capacitor is charged to the specified voltage, then discharged directly between two pins of the device with no external series resistor (internal resistor < 5 Ω). This is done for all couples of connected pin combinations while the other pins are floating.
9. Charged device model: all pins and the package are charged together to the specified voltage and then discharged directly to the ground through only one pin. This is done for all pins.

**Table 2. Operating conditions**

Symbol	Parameter	Value	Unit
$V_{CC}$	Supply voltage ( $V_{CC+} - V_{CC-}$ )	2.5 to 5.5	V
$V_{icm}$	Common mode input voltage range	$V_{CC-} -0.1$ to $V_{CC+} +0.1$	V
$T_{oper}$	Operating free-air temperature range	-40 to +150	°C

## 2 Electrical characteristics

**Table 3. Electrical characteristics at  $V_{CC+} = +2.5$  V with  $V_{CC-} = 0$  V,  $V_{icm} = V_{CC}/2$ ,  $R_L$  connected to  $V_{CC}/2$ ,  $T = 25^\circ\text{C}$  (unless otherwise specified)**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
<b>DC performance</b>						
$V_{io}$	Input offset voltage	TSV912H, $T=25^\circ\text{C}$ TSV912H, $T_{min} < T < T_{max}$		0.1	4.5 7.5	mV
		TSV912AH, $T=25^\circ\text{C}$ TSV912AH, $T_{min} < T < T_{max}$			1.5 3	
$DV_{io}/DT$	Input offset voltage drift	$-40^\circ\text{C} < T < +125^\circ\text{C}$ $+125^\circ\text{C} < T < +150^\circ\text{C}$		2 20		$\mu\text{V}/^\circ\text{C}$
$I_{io}$	Input offset current	$V_{out} = V_{CC}/2$ $T=25^\circ\text{C}$ $T_{min} < T < T_{max}$		1	$10^{(1)}$ 5	pA nA
$I_{ib}$	Input bias current	$V_{out} = V_{CC}/2$ $T=25^\circ\text{C}$ $T_{min} < T < T_{max}$		1	$10^{(1)}$ 5	pA nA
CMR	Common mode rejection ratio $20 \log (\Delta V_{ic}/\Delta V_{io})$	0V to 2.5V, $V_{out} = 1.25$ V $T=25^\circ\text{C}$ $T_{min} < T < T_{max}$	58 53	75		dB
$A_{vd}$	Large signal voltage gain	$R_L = 10\text{k}\Omega$ , $V_{out} = 0.5$ V to 2V $T=25^\circ\text{C}$ $T_{min} < T < T_{max}$	80 70	89		dB
$V_{CC}-V_{OH}$	High level output voltage	$R_L = 10\text{k}\Omega$ , $T=25^\circ\text{C}$ $R_L = 10\text{k}\Omega$ , $T_{min} < T < T_{max}$		15	40 60	mV
		$R_L = 600\Omega$ , $T=25^\circ\text{C}$ $R_L = 600\Omega$ , $T_{min} < T < T_{max}$		45	150 250	
$V_{OL}$	Low level output voltage	$R_L = 10\text{k}\Omega$ , $T=25^\circ\text{C}$ $R_L = 10\text{k}\Omega$ , $T_{min} < T < T_{max}$		15	40 60	mV
		$R_L = 600\Omega$ , $T=25^\circ\text{C}$ $R_L = 600\Omega$ , $T_{min} < T < T_{max}$		45	150 250	
$I_{out}$	$I_{sink}$	$V_{out} = 2.5$ V $T=25^\circ\text{C}$ $T_{min} < T < T_{max}$	18 14	32		mA
	$I_{source}$	$V_{out} = 0$ V $T=25^\circ\text{C}$ $T_{min} < T < T_{max}$	18 14	35		
$I_{CC}$	Supply current (per operator)	No load, $V_{out} = V_{CC}/2$ $T=25^\circ\text{C}$ $T_{min} < T < T_{max}$		0.78	1.1 1.1	mA
<b>AC performance</b>						
GBP	Gain bandwidth product	$R_L = 2\text{k}\Omega$ , $C_L = 100\text{pF}$ , $f = 100\text{kHz}$ $T=25^\circ\text{C}$ $T_{min} < T < T_{max}$		8 4		MHz

**Electrical characteristics****TSV912H, TSV912AH****Table 3. Electrical characteristics at  $V_{CC+} = +2.5$  V with  $V_{CC-} = 0$  V,  $V_{icm} = V_{CC}/2$ ,  $R_L$  connected to  $V_{CC}/2$ ,  $T = 25^\circ\text{C}$  (unless otherwise specified) (continued)**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$F_u$	Unity gain frequency	$R_L = 2\text{k}\Omega$ , $C_L = 100\text{pF}$		7.2		MHz
$\phi_m$	Phase margin	$R_L = 2\text{k}\Omega$ , $C_L = 100\text{pF}$		45		Degrees
$G_m$	Gain margin	$R_L = 2\text{k}\Omega$ , $C_L = 100\text{pF}$		8		dB
SR	Slew rate	$R_L = 2\text{k}\Omega$ , $C_L = 100\text{pF}$ , $A_v = 1$ $T = 25^\circ\text{C}$ $T_{min} < T < T_{max}$		4.5 3.5		V/ $\mu$ s
$e_n$	Equivalent input noise voltage	$f = 10\text{kHz}$		21		$\frac{\text{nV}}{\sqrt{\text{Hz}}}$
THD+ $e_n$	Total harmonic distortion	$G = 1$ , $f = 1\text{kHz}$ , $R_L = 2\text{k}\Omega$ , $Bw = 22\text{kHz}$ , $V_{icm} = (V_{CC} + 1)/2$ , $V_{out} = 1.1V_{pp}$		0.001		%

1. Guaranteed by design.

**Table 4. Electrical characteristics at  $V_{CC+} = +3.3$  V with  $V_{CC-} = 0$  V,  $V_{icm} = V_{CC}/2$ ,  $R_L$  connected to  $V_{CC}/2$ ,  $T = 25^\circ\text{C}$  (unless otherwise specified)**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
<b>DC performance</b>						
$V_{io}$	Input offset voltage	TSV912H, $T = 25^\circ\text{C}$ TSV912H, $T_{min} < T < T_{max}$		0.1	4.5 7.5	mV
		TSV912AH, $T = 25^\circ\text{C}$ TSV912AH, $T_{min} < T < T_{max}$			1.5 3	
$DV_{io}$	Input offset voltage drift	$-40^\circ\text{C} < T < +125^\circ\text{C}$ $+125^\circ\text{C} < T < +150^\circ\text{C}$		2 20		$\mu\text{V}/^\circ\text{C}$
$I_{io}$	Input offset current	$V_{out} = V_{CC}/2$ $T = 25^\circ\text{C}$ $T_{min} < T < T_{max}$		1	$10^{(1)}$ 5	pA nA
$I_{ib}$	Input bias current	$V_{out} = V_{CC}/2$ $T = 25^\circ\text{C}$ $T_{min} < T < T_{max}$		1	$10^{(1)}$ 5	pA nA
CMR	Common mode rejection ratio $20 \log (\Delta V_{ic}/\Delta V_{io})$	0V to 3.3V, $V_{out} = 1.65\text{V}$ $T = 25^\circ\text{C}$ $T_{min} < T < T_{max}$	60 55	78		dB
$A_{vd}$	Large signal voltage gain	$R_L = 10\text{k}\Omega$ , $V_{out} = 0.5\text{V}$ to $2.8\text{V}$ $T = 25^\circ\text{C}$ $T_{min} < T < T_{max}$	80 70	90		dB
$V_{CC}-V_{OH}$	High level output voltage	$R_L = 10\text{k}\Omega$ , $T = 25^\circ\text{C}$ $R_L = 10\text{k}\Omega$ , $T_{min} < T < T_{max}$ $R_L = 600\Omega$ , $T = 25^\circ\text{C}$ $R_L = 600\Omega$ , $T_{min} < T < T_{max}$		15 45	40 150 250 60	mV

**Table 4. Electrical characteristics at  $V_{CC+} = +3.3$  V with  $V_{CC-} = 0$  V,  $V_{icm} = V_{CC}/2$ ,  $R_L$  connected to  $V_{CC}/2$ ,  $T = 25^\circ\text{C}$  (unless otherwise specified) (continued)**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$V_{OL}$	Low level output voltage	$R_L = 10\text{k}\Omega, T=25^\circ\text{C}$ $R_L = 10\text{k}\Omega, T_{min} < T < T_{max}$ $R_L = 600\Omega, T=25^\circ\text{C}$ $R_L = 600\Omega, T_{min} < T < T_{max}$		15 45	40 150 250	mV
$I_{out}$	$I_{sink}$	$V_{out} = 3.3\text{V}$ $T=25^\circ\text{C}$ $T_{min} < T < T_{max}$	18 14	32		mA
	$I_{source}$	$V_{out} = 0\text{V}$ $T=25^\circ\text{C}$ $T_{min} < T < T_{max}$	18 14	35		
$I_{CC}$	Supply current (per operator)	No load, $V_{out} = V_{CC}/2$ $T=25^\circ\text{C}$ $T_{min} < T < T_{max}$		0.8	1.1 1.1	mA
<b>AC performance</b>						
GBP	Gain bandwidth product	$R_L = 2\text{k}\Omega, C_L = 100\text{pF}, f = 100\text{kHz}$ , $T=25^\circ\text{C}$ $T_{min} < T < T_{max}$		8 4.2		MHz
$F_u$	Unity gain frequency	$R_L = 2\text{k}\Omega, C_L = 100\text{pF}$		7.2		MHz
$\phi_m$	Phase margin	$R_L = 2\text{k}\Omega, C_L = 100\text{pF}$		45		Degrees
$G_m$	Gain margin	$R_L = 2\text{k}\Omega, C_L = 100\text{pF}$		8		dB
SR	Slew rate	$R_L = 2\text{k}\Omega, C_L = 100\text{pF}, A_v = 1$ , $T=25^\circ\text{C}$ $T_{min} < T < T_{max}$		4.5 3.5		V/ $\mu$ s
$e_n$	Equivalent input noise voltage	$f = 10\text{kHz}$		21		$\frac{\text{nV}}{\sqrt{\text{Hz}}}$
THD+ $e_n$	Total harmonic distortion	$G = 1, f = 1\text{kHz}, R_L = 2\text{k}\Omega, BW = 22\text{kHz}$ , $V_{icm} = (V_{CC} + 1)/2, V_{out} = 1.9V_{pp}$ ,		0.0007		%

1. Guaranteed by design.

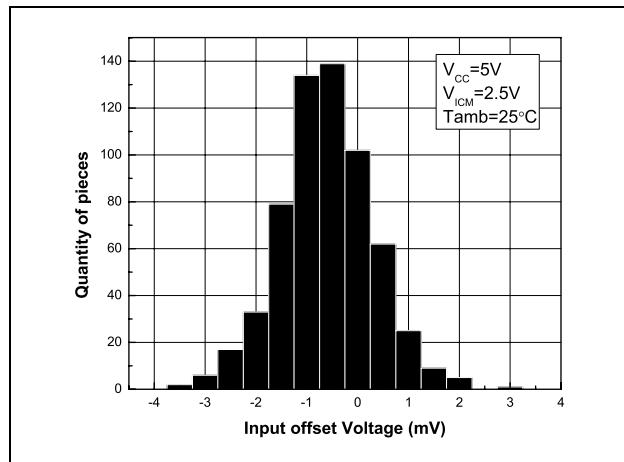
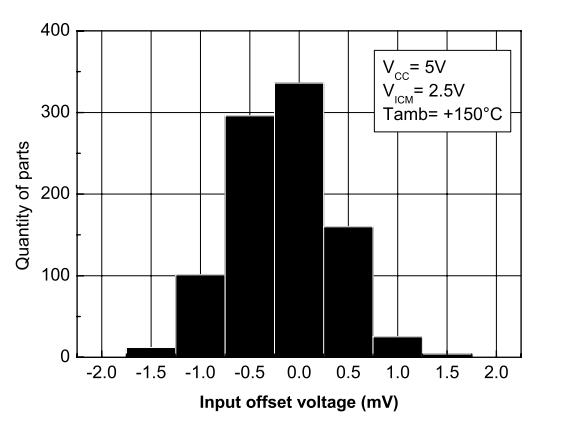
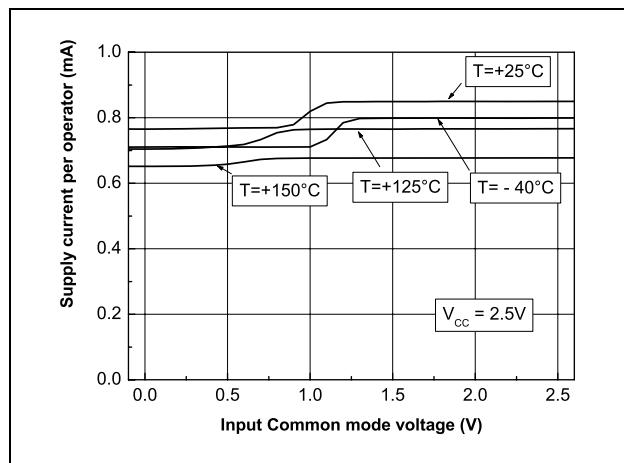
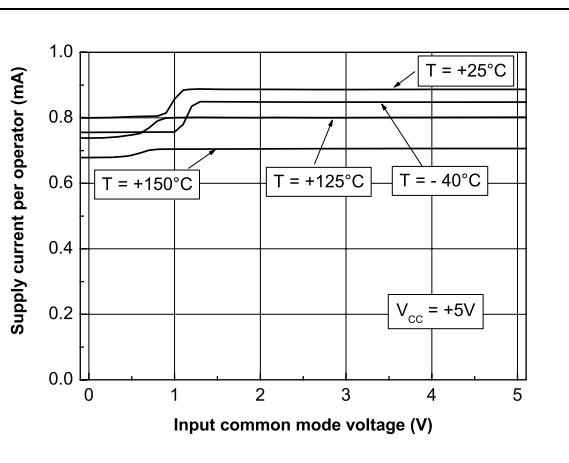
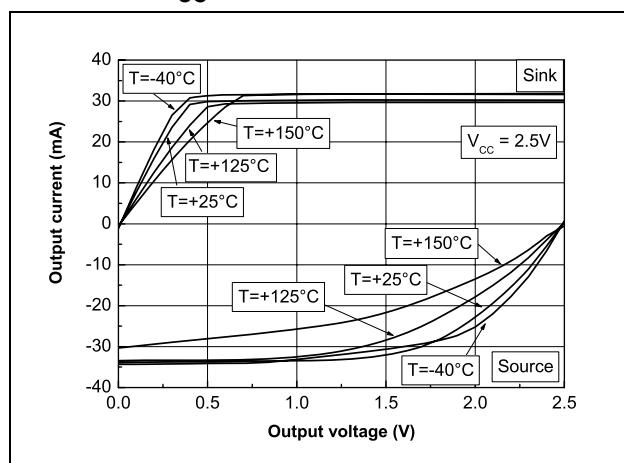
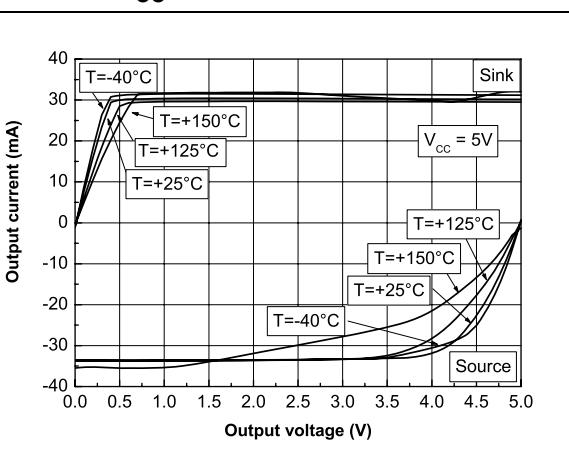
**Electrical characteristics****TSV912H, TSV912AH****Table 5. Electrical characteristics at  $V_{CC+} = +5$  V with  $V_{CC-} = 0$  V,  $V_{icm} = V_{CC}/2$ ,  $R_L$  connected to  $V_{CC}/2$ , full temperature range (unless otherwise specified)**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
<b>DC performance</b>						
$V_{io}$	Input offset voltage	TSV912H, $T=25^\circ C$ TSV912H, $T_{min} < T < T_{max}$		0.1	4.5 7.5	mV
		TSV912AH, $T=25^\circ C$ TSV912AH, $T_{min} < T < T_{max}$			1.5 3	
$DV_{io}$	Input offset voltage drift	$-40^\circ C < T < +125^\circ C$ $+125^\circ C < T < +150^\circ C$		2 20		$\mu V/^\circ C$
$I_{io}$	Input offset current	$V_{out} = V_{CC}/2$ $T=25^\circ C$ $T_{min} < T < T_{max}$		1	$10^{(1)}$ 5	pA nA
$I_{ib}$	Input bias current	$V_{out} = V_{CC}/2$ $T=25^\circ C$ $T_{min} < T < T_{max}$		1	$10^{(1)}$ 5	pA nA
CMR	Common mode rejection ratio 20 log ( $\Delta V_{ic}/\Delta V_{io}$ )	0V to 5V, $V_{out} = 2.5V$ $T=25^\circ C$ $T_{min} < T < T_{max}$	62 58	82		dB
SVR	Supply voltage rejection ratio 20 log ( $\Delta V_{CC}/\Delta V_{io}$ )	$V_{CC} = 2.5$ to 5V $T=25^\circ C$ $T_{min} < T < T_{max}$	70 65	86		dB
$A_{vd}$	Large signal voltage gain	$R_L = 10k\Omega$ , $V_{out} = 0.5V$ to 4.5V $T=25^\circ C$ $T_{min} < T < T_{max}$	80 70	91		dB
$V_{CC}-V_{OH}$	High level output voltage	$R_L = 10k\Omega$ , $T=25^\circ C$ $R_L = 10k\Omega$ , $T_{min} < T < T_{max}$ $R_L = 600\Omega$ , $T=25^\circ C$ $R_L = 600\Omega$ , $T_{min} < T < T_{max}$		15 45	40 60 150 250	mV
$V_{OL}$	Low level output voltage	$R_L = 10k\Omega$ , $T=25^\circ C$ $R_L = 10k\Omega$ , $T_{min} < T < T_{max}$ $R_L = 600\Omega$ , $T=25^\circ C$ $R_L = 600\Omega$ , $T_{min} < T < T_{max}$		15 45	40 60 150 250	mV
$I_{out}$	$I_{sink}$	$V_{out} = 5V$ $T=25^\circ C$ $T_{min} < T_{op} < T_{max}$	18 14	32		mA
	$I_{source}$	$V_{out} = 0V$ $T=25^\circ C$ $T_{min} < T_{op} < T_{max}$	18 14	35		
$I_{CC}$	Supply current (per operator)	No load, $V_{out} = 2.5V$ $T=25^\circ C$ $T_{min} < T_{op} < T_{max}$		0.82	1.1 1.1	mA

**Table 5. Electrical characteristics at  $V_{CC+} = +5$  V with  $V_{CC-} = 0$  V,  $V_{icm} = V_{CC}/2$ ,  $R_L$  connected to  $V_{CC}/2$ , full temperature range (unless otherwise specified) (continued)**

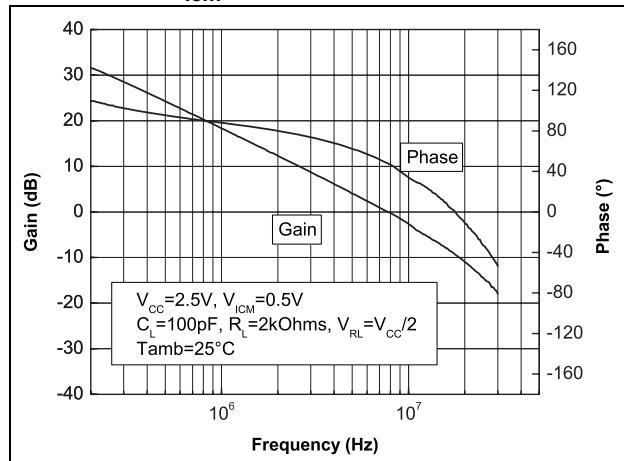
Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
<b>AC performance</b>						
GBP	Gain bandwidth product	$R_L = 2k\Omega$ , $C_L = 100pF$ , $f = 100kHz$ $T = 25^\circ C$ $T_{min} < T_{op} < T_{max}$		8 4.5		MHz
$F_u$	Unity gain frequency	$R_L = 2k\Omega$ , $C_L = 100pF$		7.5		MHz
$\phi_m$	Phase margin	$R_L = 2k\Omega$ , $C_L = 100pF$		45		Degrees
$G_m$	Gain margin	$R_L = 2k\Omega$ , $C_L = 100pF$		8		dB
SR	Slew rate	$R_L = 2k\Omega$ , $C_L = 100pF$ , $A_V = 1$ $T = 25^\circ C$ $T_{min} < T_{op} < T_{max}$		4.5 3.5		V/ $\mu$ s
$e_n$	Equivalent input noise voltage	$f = 1kHz$ $f = 10kHz$		27 21		nV/ $\sqrt{Hz}$
THD+ $e_n$	Total harmonic distortion	$G = 1$ , $f = 1kHz$ , $R_L = 2k\Omega$ , $Bw = 22kHz$ , $V_{icm} = (V_{CC} + 1)/2$ , $V_{out} = 3.6V_{pp}$		0.0004		%

1. Guaranteed by design.

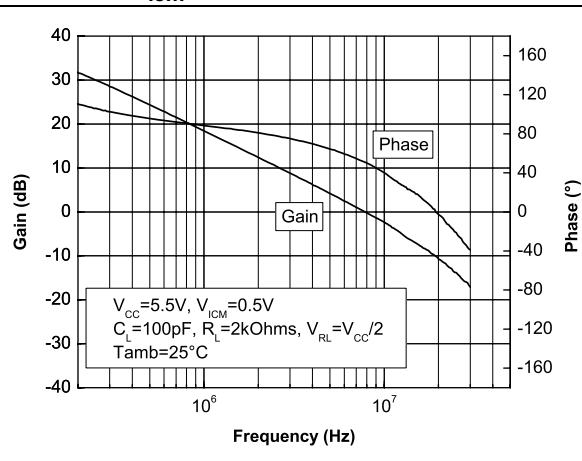
**Electrical characteristics****TSV912H, TSV912AH****Figure 1. Input offset voltage distribution at  $T = 25^\circ C$** **Figure 2. Input offset voltage distribution at  $T = 150^\circ C$** **Figure 3. Supply current vs. input common-mode voltage at  $V_{CC} = 2.5 V$** **Figure 4. Supply current vs. input common-mode voltage at  $V_{CC} = 5 V$** **Figure 5. Output current vs. output voltage at  $V_{CC} = 2.5 V$** **Figure 6. Output current vs. output voltage at  $V_{CC} = 5 V$** 

**TSV912H, TSV912AH****Electrical characteristics**

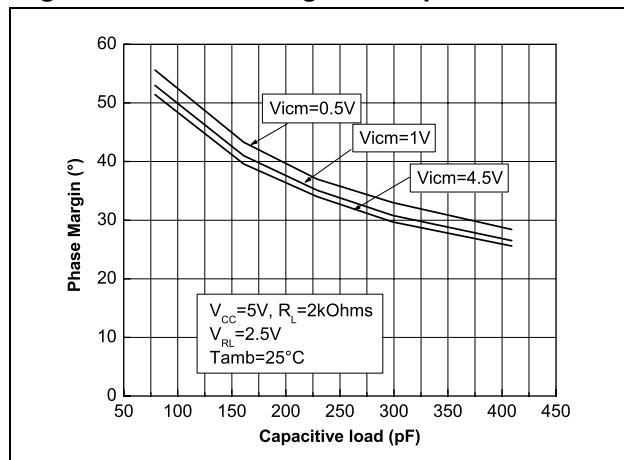
**Figure 7. Voltage gain and phase vs frequency at  $V_{CC} = 2.5$  V and  $V_{ICM} = 0.5$  V**



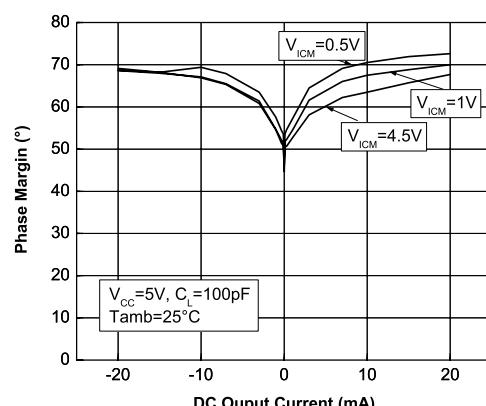
**Figure 8. Voltage gain and phase vs frequency at  $V_{CC} = 5.5$  V and  $V_{ICM} = 0.5$  V**



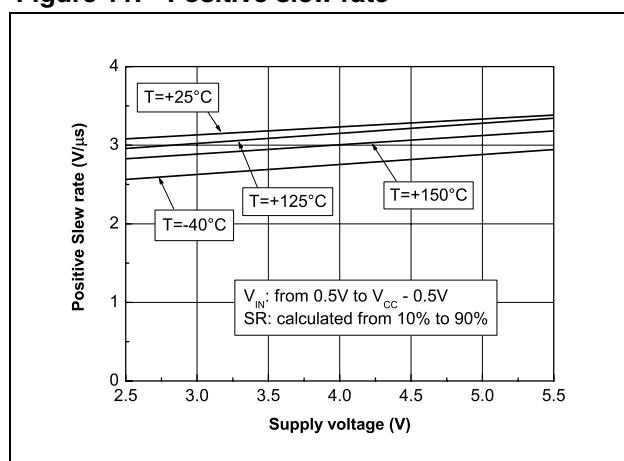
**Figure 9. Phase margin vs. capacitive load**



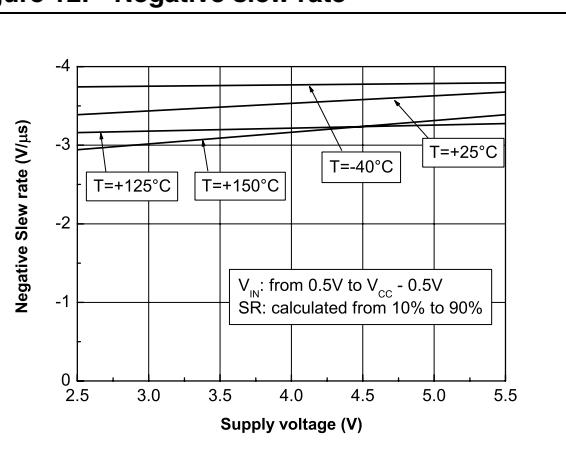
**Figure 10. Phase margin vs. output current**

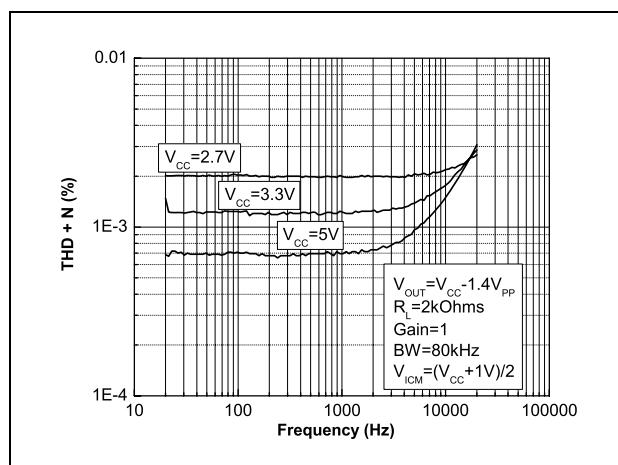
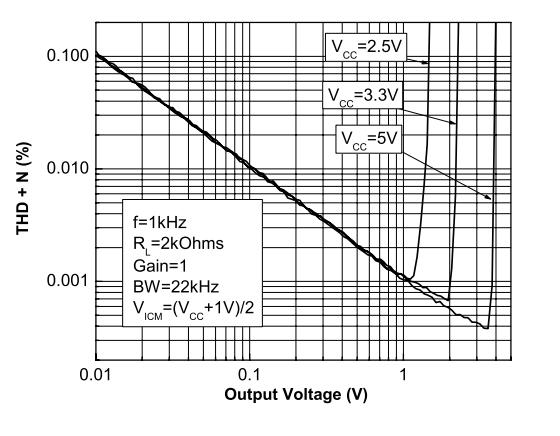
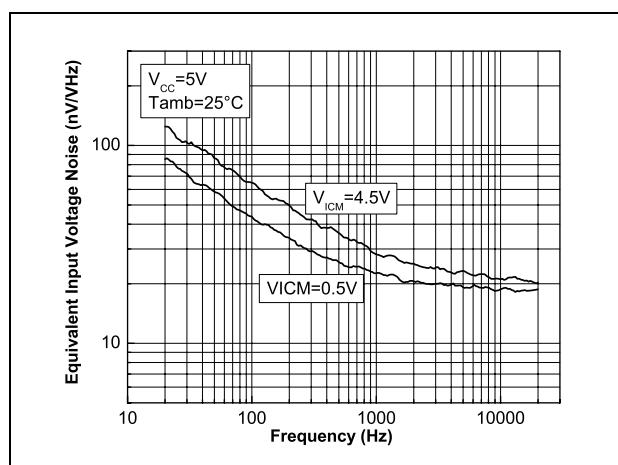
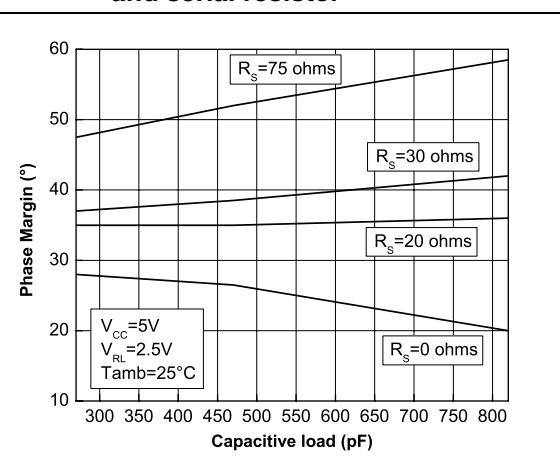
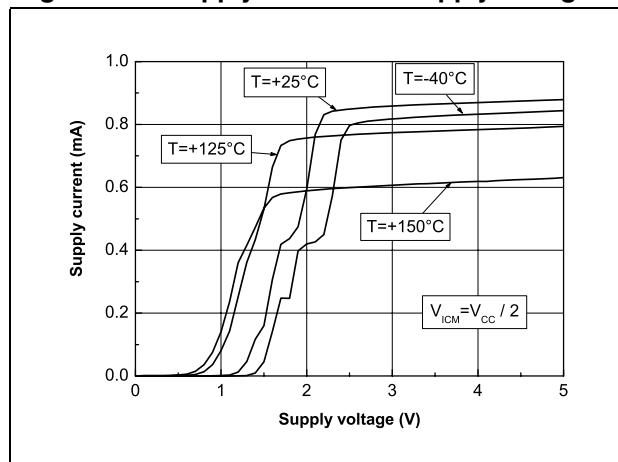


**Figure 11. Positive slew rate**



**Figure 12. Negative slew rate**



**Electrical characteristics****TSV912H, TSV912AH****Figure 13. Distortion + noise vs. frequency****Figure 14. Distortion + noise vs. output voltage****Figure 15. Noise vs. frequency****Figure 16. Phase margin vs. capacitive load and serial resistor****Figure 17. Supply current vs. supply voltage**

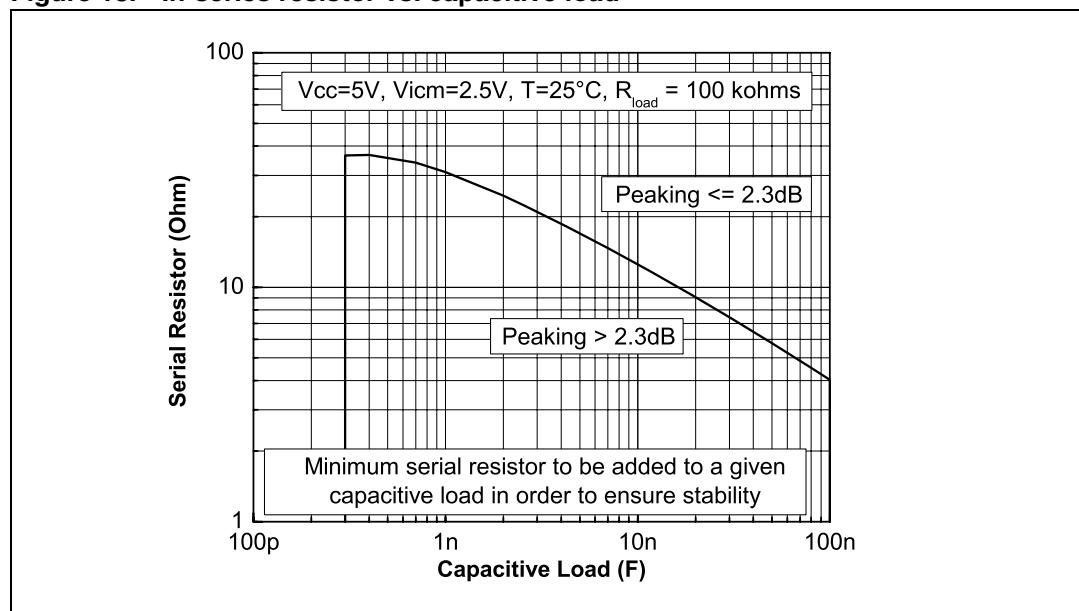
## 3 Application information

### 3.1 Driving resistive and capacitive loads

These products are low-voltage, low-power operational amplifiers optimized to drive rather large resistive loads above 2 k $\Omega$ .

In a *follower* configuration, these operational amplifiers can drive capacitive loads up to 100 pF with no oscillations. When driving larger capacitive loads, adding a small in-series resistor at the output can improve the stability of the devices (see [Figure 18](#) for recommended in-series resistor values). Once the in-series resistor value has been selected, the stability of the circuit should be tested on bench and simulated with the simulation model.

**Figure 18. In-series resistor vs. capacitive load**



### 3.2 PCB layouts

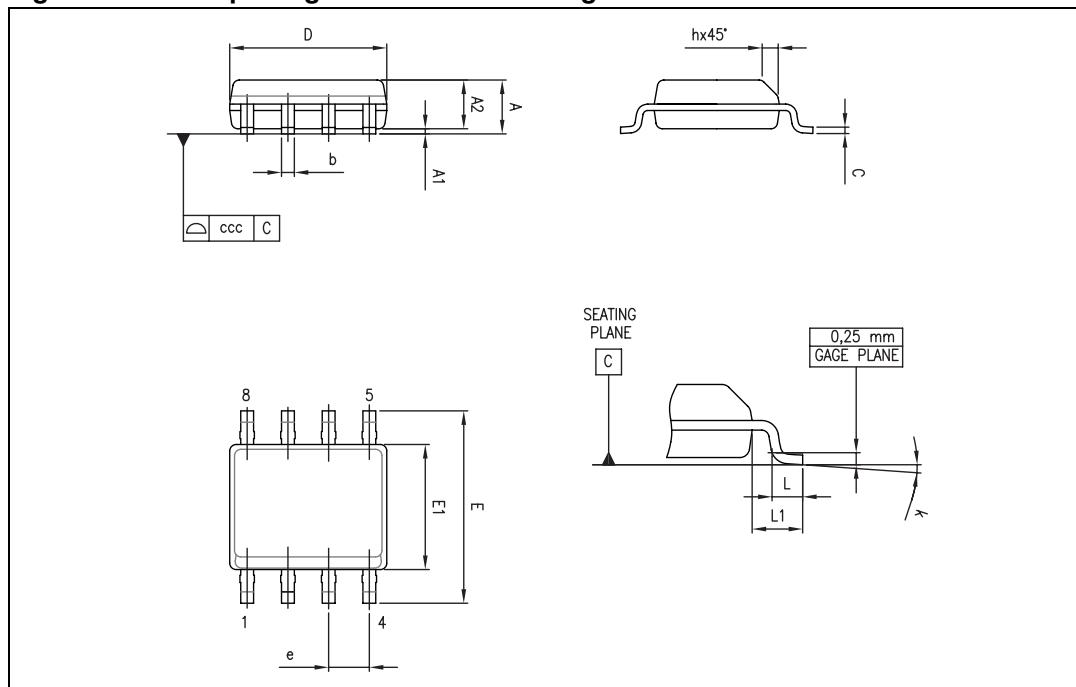
For correct operation, it is advised to add 10 nF decoupling capacitors as close as possible to the power supply pins.

## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).  
ECOPACK® is an ST trademark.

## 4.1 SO-8 package information

**Figure 19.** SO-8 package mechanical drawing



**Table 6.** SO-8 package mechanical data

Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A			1.75			0.069
A1	0.10		0.25	0.004		0.010
A2	1.25			0.049		
b	0.28		0.48	0.011		0.019
c	0.17		0.23	0.007		0.010
D	4.80	4.90	5.00	0.189	0.193	0.197
E	5.80	6.00	6.20	0.228	0.236	0.244
E1	3.80	3.90	4.00	0.150	0.154	0.157
e		1.27			0.050	
h	0.25		0.50	0.010		0.020
L	0.40		1.27	0.016		0.050
L1		1.04			0.040	
k	0		8°	1°		8°
ccc			0.10			0.004

## 5 Ordering information

**Table 7. Order codes**

Order code	Temperature range	Package	Packing	Marking
TSV912HYDT <sup>(1)</sup>	-40°C to +150°C	SO-8 <sup>(2)</sup> (automotive grade level)	Tape & reel	V912HY
TSV912AHYDT <sup>(1)</sup>				V912AHY

1. Qualification and characterization according to AEC Q100 and Q003 or equivalent, advanced screening according to AEC Q001 & Q 002 or equivalent.
2. SO8 package is Moisture Sensitivity Level 1 as per Jедес J-STD-020-C.

## 6 Revision history

**Table 8. Document revision history**

Date	Revision	Changes
08-Jul-2010	1	Initial release.

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